

Notice of References Cited

Application/Control No.

10/500,055

Applicant(s)/Patent Under
Reexamination
ONUKI, HIDEO

Examiner

DANIEL MCNALLY

Art Unit

1791

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0116273	06-2003	Nakamura et al.	156/330
*	B	US-6,655,433	12-2003	Hirayama et al.	156/436
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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